

<b>Notice of References Cited</b>	Application/Control No. 10/664,950		Applicant(s)/Patent Under Reexamination YEH ET AL.	
	Examiner Ngoc-Yen M. Nguyen		Art Unit 1754	Page 1 of 1

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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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